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Substitute for form 1449/PTO INFORMATION DISCLOSURE STATEMENT BY APPLICANT (use as many sheets as necessary)		Complete if Known			
		Application Number	10/824,598		
		Filing Date	April 15, 2004		
		First Named Inventor	LEE, Yun-Bok		
		Art Unit	2871		
		Examiner Name	Vu, Phu		
Sheet	1	of	1	Attorney Docket Number	8734.292 US

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code ² (if known)			
P.V.	AA	6,078,375	06-20-2000	Matsumoto et al.	
C.V.		5,977,562	11-02-1999	Hirakata et al.	
P.V.		4,609,255	09-02-1986	Leenhouts et al.	

FOREIGN PATENT DOCUMENTS						
Examiner Initials*	Cite No.	Foreign Patent Document	Publication Date	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T
		Country Code ² -Number ² -Kind Code ² (if known)	MM-DD-YYYY			
P.V.	BA	JP 9-325328 A	12-16-1997	HITACHI LTD	Abstract	

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NON PATENT LITERATURE DOCUMENTS			
Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ³
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Examiner Signature		Date Considered	12/17/07
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P.V.	AA	5,977,562 A	11/02/199	Hirakata et al.	
P.V.	AB	6,243,154 B1	06/05/2001	You et al.	
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Examiner Initials*	Cite No. ¹	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ³
		Country Code ² -Number-Kind Code ³ (if known)				
P.V.	BA	JP 2003-131250	05/08/2003	Nanox Corporation		
P.V.	BB	JP 2003-015146	01/15/2003	Hitachi Ltd.		
P.V.	BC	JP 2001-154214	06/08/2001	Casio Comput Co. Ltd.		
P.V.	BD	JP 2002-169183	06/14/2002	Matsushita Electric Ind. Co. Ltd.		
P.V.	BE	JP 09-105908	04/22/1997	Hitachi Ltd.		
P.V.	WO	03/012536 A1	02/13/2003	Samsung Electronics Co. Ltd.		

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Examiner Signature		Date Considered	12/18/04
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